



DATE: 12th July, 2016

PCN #: 2196

PCN Title: Additional Qualified (FAB) Wafer Fabrication / (AT) Assembly Test Sites on selected devices

Dear Customer:

This is an announcement of change(s) to products that are currently being offered by Diodes Incorporated.

We request that you acknowledge receipt of this notification within 30 days of the date of this PCN. If you require samples for evaluation purposes, please make a request within 30 days as well. Otherwise, samples may not be built prior to this change. Please refer to the implementation date of this change as it is stated in the attached PCN form. Please contact your local Diodes sales representative to acknowledge receipt of this PCN and for any sample requests.

The changes announced in this PCN will not be implemented earlier than 90 days from the notification date stated in the attached PCN form.

Previously agreed upon customer specific change process requirements or device specific requirements will be addressed separately.

For questions or clarification regarding this PCN, please contact your local Diodes sales representative.

Sincerely,

Diodes Incorporated PCN Team



PRODUCT CHANGE NOTICE

PCN-2196 REV 00

Notification Date:	Implementation Date:	Product Family:	Change Type:	PCN #:
12 th July, 2016	10 th Oct, 2016	Analog Semiconductors	Additional FAB/AT Sites	2196
TITLE				
Additional Qualified (FAB) Wafer Fabrication / (AT) Assembly Test Sites on selected devices				
DESCRIPTION OF CHANGE				
This PCN is being issued to notify customers that in order to assure continuity of supply, Diodes has qualified additional FAB/AT Sites on selected devices. Full electrical characterization and high reliability testing has been completed on representative part numbers to ensure there is no change to device functionality or electrical specifications in the datasheet.				
IMPACT				
Continuity of Supply. No change in data sheet parameters and product performance.				
PRODUCTS AFFECTED				
Please see the parts list below in the following Tables: Table 1 - Qualify Additional AT Source (HuaDa) Nantong Huada Microelectronics Co., Ltd. Jiangsu, China Table 2 - Qualify Additional Fab Source (SFAB2) Diodes Shanghai SIM-BCD Semiconductor Manufacturing Co., Shanghai, China and AT Source (SAT) Diodes Incorporated / Shanghai, China Table 3 - Qualify Additional AT Source (SAT) Diodes Incorporated / Shanghai, China Table 4 - Qualify Additional AT Source (CAT) Diodes Incorporated / Chengdu, China Table 5 - Qualify Additional AT Source (UNISEM) UNISEM Chengdu Co., Ltd. Chengdu, China				
WEB LINKS				
Manufacturer's Notice:	http://www.diodes.com/quality/pcns			
For More Information Contact:	http://www.diodes.com/contacts			
Data Sheet:	http://www.diodes.com/products			
DISCLAIMER				
Unless a Diodes Incorporated Sales representative is contacted in writing within 30 days of the posting of this notice, all changes described in this announcement are considered approved.				

Table 1 - Qualify Additional AT Source (HuaDa)

AH276Q-PG-B-A	AH276Q-PG-B-B	AH276Q-PG-B-C	AH2984-PG-B		
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Table 2 - Qualify Additional Fab Source (SFAB2) / AT Source (SAT)

AP3586AMPTR-G1	AP3586BMPTR-G1	AP3586CMPTR-G1	AP3586AMTR-G1	AP3586BMTR-G1	AP3586CMTR-G1
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Table 3 - Qualify Additional AT Source (SAT)

LM4041CFTA	LM4041DFTA	LM4041DADJFTA			
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Table 4 - Qualify Additional AT Source (CAT)

AL9910AS-13	AL9910A-5S-13	AL9910ASP-13	AL9910A-5SP-13	74LVC1G10W6-7	74LVC1G11W6-7
74LVC1G57W6-7	74LVC1G58W6-7	74LVC1G97W6-7	74LVC1G98W6-7		

Table 5 - Qualify Additional AT Source (Unisem)

AP91350MN1-DT8-7					
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